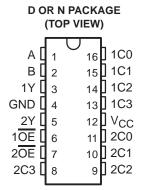
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- **Inverting Version of 74AC11253**
- Permits Multiplexing from N Lines to 1 Line
- **Performs Parallel-to-Serial Conversion**
- Flow-Through Architecture Optimizes PCB Layout
- Center-Pin V_{CC} and GND Configurations **Minimize High-Speed Switching Noise**
- **EPIC** ™ (Enhanced-Performance Implanted CMOS) 1-µm Process
- **Package Options Include Plastic** Small-Outline Packages, and Standard Plastic 300-mil DIPs



description

Each of these data selectors/multiplexers contains inverters and drivers to supply full binary decoding data selection to the AND-OR gates. Separate strobe output-enable (1OE or 2OE) inputs are provided for each of the two four-line sections.

The 3-state outputs can interface with and drive data lines of bus-organized systems. With all but one of the common outputs disabled (at a high-impedance state), the low impedance of the single enabled output will drive the bus line to a high or low logic level. Each output has its own strobe. The output is disabled when its strobe is high.

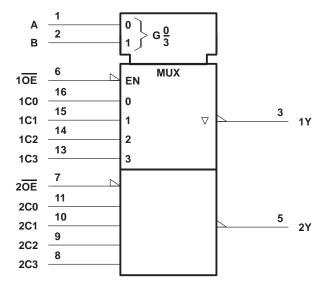
The 74AC11353 is characterized for operation from −40°C to 85°C.

FUNCTION TABLE

SELECT INPUTS			DATA I	NPUTS	STROBE OE	ОИТРИТ				
В	Α	C0	C1	C2	C3	OE .	Ť			
Х	Х	Х	Χ	Х	Χ	Н	Z			
L	L	L	X	X	X	L	Н			
L	L	Н	X	X	X	L	L			
L	Н	X	L	X	X	L	Н			
L	Н	X	Н	X	X	L	L			
Н	L	Х	Χ	L	Χ	L	Н			
Н	L	Х	Χ	Н	Χ	L	L			
Н	Н	Х	Χ	Χ	L	L	Н			
Н	Н	Х	Χ	X	Н	L	L			

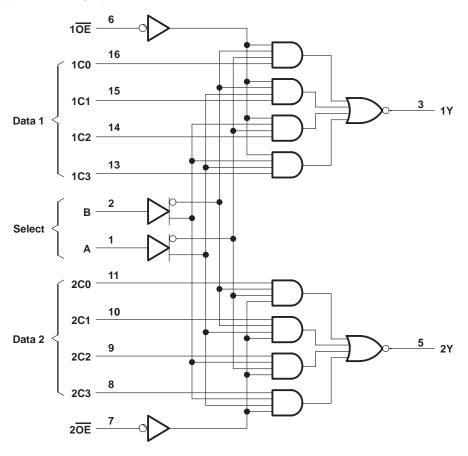
EPIC is a trademark of Texas Instruments Incorporated.

logic symbol†



[†] This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

logic diagram (positive logic)





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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage range, V _{CC}	−0.5 V to 7 V
Input voltage range, V _I (see Note 1)	0.5 V to V _{CC} + 0.5 V
Output voltage range, VO (see Note 1)	
Input clamp current, I_{IK} ($V_I < 0$ or $V_I > V_{CC}$)	±20 mA
Output clamp current, IOK (VO < 0 or VO > VCC)	±50 mA
Continuous output current, $I_O(V_O = 0 \text{ to } V_{CC})$	±50 mA
Continuous current through V _{CC} or GND pins	±100 mA
Storage temperature range	–65°C to 150°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: The input and output voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

recommended operating conditions

			MIN	NOM	MAX	UNIT	
Vcc	Supply voltage		3	5	5.5	V	
		V _{CC} = 3 V	2.1			V	
VIH	High-level input voltage	$V_{CC} = 4.5 \text{ V}$	3.15				
		$V_{CC} = 5.5 \text{ V}$	3.85				
		V _{CC} = 3 V			0.9		
V _{IL}	Low-level input voltage	$V_{CC} = 4.5 \text{ V}$		1.35 1.65 0 V _{CC}		V	
	Low-level input voltage Input voltage Output voltage	$V_{CC} = 5.5 \text{ V}$			1.65		
٧ _I	Input voltage		0		VCC	V	
٧o	Output voltage		0		VCC	V	
		V _{CC} = 3 V			-4		
IOH	High-level output current	V _{CC} = 4.5 V			-24	mA	
		$V_{CC} = 5.5 \text{ V}$	-2		-24		
		V _{CC} = 3 V			12		
IOL	Low-level output current	$V_{CC} = 4.5 \text{ V}$		24	mA		
		$V_{CC} = 5.5 \text{ V}$			24		
Δt/Δν	Input transition rise or fall rate		0		10	ns/V	
TA	Operating free-air temperature		-40		85	°C	

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electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS		T _A = 25°C			MIN	MAX	UNIT
PARAMETER			MIN	TYP	MAX	IVIIIV	IVIAA	ONIT
			2.9			2.9		
	ΙΟΗ = – 50 μΑ	4.5 V	4.4			4.4		
		5.5 V	5.4			5.4		
Voн	$I_{OH} = -4 \text{ mA}$	3 V	2.58			2.48		V
		4.5 V	3.94			3.8		
	I _{OH} = -24 mA	5.5 V	4.94			4.8		
	$I_{OH} = -75 \text{ mA}^{\dagger}$	5.5 V				3.85		
	I _{OL} = 50 μA				0.1		0.1	
					0.1		0.1	
		5.5 V			0.1		0.1	
VOL	I _{OL} = 12 mA	3 V			0.36		0.44	V
	lo 24 mA	4.5 V			0.36		0.44	
	I _{OL} = 24 mA				0.36		0.44	
	$I_{OL} = 75 \text{ mA}^{\dagger}$	5.5 V					1.65	
IĮ	$V_I = V_{CC}$ or GND	5.5 V			±0.1		±1	μΑ
loz	$V_O = V_{CC}$ or GND	5.5 V			±0.5		±5	μΑ
lcc	$V_I = V_{CC}$ or GND, $I_O = 0$	5.5 V			8		80	μΑ
Ci	$V_I = V_{CC}$ or GND	5 V		3.5				pF
CO	$V_O = V_{CC}$ or GND	5 V		8				pF

[†] Not more than one output should be tested at a time, and the duration of the test should not exceed 10 ms.

switching characteristics over recommended operating free-air temperature range, V_{CC} = 3.3 V \pm 0.3 V (unless otherwise noted) (see Figure 1)

PARAMETER	FROM	то	T _A = 25°C			MIN	MAX	UNIT
PARAMETER	(INPUT)	(OUTPUT)	MIN	TYP	MAX	IVIIIV	IVIAA	UNIT
^t PLH	A or B	Y	1.5	7	9.6	1.5	10.7	ns
^t PHL			1.5	7.2	9.8	1.5	10.9	
^t PLH	Any C	Y	1.5	6.5	8.6	1.5	9.6	20
tPHL		ī	1.5	6.6	8.7	1.5	9.7	ns
^t PZH	OE	Υ	1.5	4.4	6	1.5	6.6	ne
t _{PZL}		ı	1.5	5.4	7.2	1.5	7.9	ns
t _{PHZ}	OE	Y	1.5	4.8	6.2	1.5	6.5	ne
tPLZ		1	1.5	4.9	6.3	1.5	6.6	ns

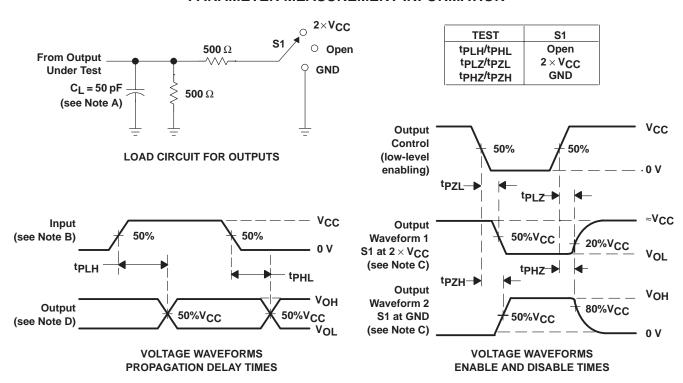
switching characteristics over recommended operating free-air temperature range, V_{CC} = 5 V \pm 0.5 V (unless otherwise noted) (see Figure 1)

PARAMETER	FROM	TO (OUTPUT)	T _A = 25°C			MIN	MAX	UNIT
PARAMETER	(INPUT)		MIN	TYP	MAX	IVIIIV	IVIAA	ONIT
^t PLH	A or B	Υ	1.5	4.5	6.6	1.5	7.4	ns
^t PHL		T	1.5	4.6	6.9	1.5	7.6	
t _{PLH}	Any C	Y	1.5	4	5.9	1.5	6.6	ns
^t PHL		'	1.5	4.2	6.1	1.5	6.8	113
^t PZH	OE	Υ	1.5	2.9	4.4	1.5	4.8	ns
^t PZL		ī	1.5	3.4	5.1	1.5	5.6	110
^t PHZ	OE	Y	1.5	4.4	5.8	1.5	6.1	ns
t _{PLZ}	J OE	ſ	1.5	4.1	5.5	1.5	5.8	115

operating characteristics, V_{CC} = 5 V, T_A = 25°C

PARAMETER			TEST C	TYP	UNIT	
C _{pd}	Down dissination consistence nor multipleyer	Outputs enabled	C _L = 50 pF,	f = 1 MHz	31	F
	Power dissipation capacitance per multiplexer	Outputs disabled		f = 1 MHz	12	pF

PARAMETER MEASUREMENT INFORMATION



NOTES: A. C_L includes probe and jig capacitance.

- B. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, $Z_0 = 50 \Omega$, $t_f \leq 3$ ns, $t_f \leq 3$ ns. For testing pulse duration: $t_r = t_f = 1$ to 3 ns. Pulse polarity can be either high-to-low-to-high or low-to-high-to-low.
- C. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- D. The outputs are measured one at a time with one transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms



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